■ Max r <sub>DS(on)</sub>	= 5.7 m $\Omega$ at $~V_{GS}$ = 4.5 V, I_D = 17 A	improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low r <sub>DS(on)</sub> , fast switching speed and body diode reverse recovery performance.				
■ State-of-the	-art switching performance					
Lower output boost efficie	ut capacitance, gate resistance, and gate charge ency					
Shielded aa	ate technology reduces switch node ringing and	Applications				
•	nmunity to EMI and cross conduction	High side switching for high end computing				
RoHS Comp	pliant	High power density DC-DC synchronous buck converter				
Pin 1 To MOSFET	$Dual Cool^{TM} 33 Bottom$ Maximum Ratings T <sub>A</sub> = 25 °C unless of	$S = \begin{bmatrix} 1 & 0 \\ 0 & 0 $				
Symbol	Parameter	Ratings Units				
V <sub>DS</sub>	Drain to Source Voltage	(Note 5) 25 V				
V <sub>GS</sub>	Gate to Source Voltage	(Note 4) ±12 V				

N-Channel Dual Cool<sup>TM</sup> 33 PowerTrench<sup>®</sup> MOSFET

February 2016

Symbol	Parameter		Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage	(Note 5)	25	V
V <sub>GS</sub>	Gate to Source Voltage	(Note 4)	±12	V
	Drain Current - Continuous (Package limited) T <sub>C</sub> = 25 °C		40	
	- Continuous (Silicon Limited) T <sub>C</sub> = 25 °C		73	A
D	- Continuous	(Note 1a)	17	A
	- Pulsed		60	
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 3)	29	mJ
D	Power Dissipation $T_{C} = 25 \text{ °C}$		41	w
PD	Power Dissipation $T_A = 25 \degree C$	(Note 1a)	3.0	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

**General Description** 

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node

## **Thermal Characteristics**

FAIRCHILD

FDMC8588DC

**25 V, 40 A, 5.7 m**Ω

■ Dual Cool<sup>TM</sup> Top Side Cooling PQFN package

Features

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Top Source)	7.0	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	3.0	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
08DC	FDMC8588DC	Dual Cool <sup>™</sup> 33	13 "	12 mm	3000 units

FDMC8588DC N
N-Channel Dual Cool
M
33 PowerTrench <sup>®</sup>
MOSFET

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Off Chara	acteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D$ = 250 $\mu$ A , $V_{GS}$ = 0 V	25			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 µA , referenced to 25 °C		5		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1	μA
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	V <sub>GS</sub> = 12 V, V <sub>DS</sub> = 0 V			100	nA
On Chara	octeristics					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	0.8	1.2	1.8	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 µA , referenced to 25 °C		-4		mV/°C
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 18 A		3.6	5.0	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 17 A		4.1	5.7	mΩ
		$V_{GS}$ = 10 V, $I_{D}$ = 18 A, $T_{J}$ = 125 °C		5.5	7.6	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DD</sub> = 5 V, I <sub>D</sub> = 17 A		103		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance			1695		pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 13 V, V <sub>GS</sub> = 0 V, f = 1 MHz		493		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			63		pF
R <sub>g</sub>	Gate Resistance			0.4		Ω
Switching	g Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time			8		ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 13 V, I <sub>D</sub> = 17A,		3		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		25		ns
t <sub>f</sub>	Fall Time			2		ns
Q <sub>g(TOT)</sub>	Total Gate Charge at 4.5V			12		nC
Q <sub>gs</sub>	Total Gate Charge	V <sub>DD</sub> = 13 V, I <sub>D</sub> = 17 A		3.0		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	1		3.0		nC

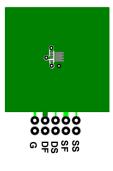
V	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2 A$ (	Note 2)	0.7	1.2	V
V <sub>SD</sub> Source to Drain Diode Forward voltage		$V_{GS} = 0 V, I_S = 17 A$ (	Note 2)	0.8	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 17 A, di/dt = 100 A/μs		25		ns
Q <sub>rr</sub>	Reverse Recovery Charge			10		nC

# **Thermal Characteristics**

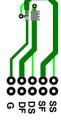
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Top Source)	7.0	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	3.0	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	29	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	40	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	19	*CAN/
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	23	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	30	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	79	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	16	

Notes:

1.  $R_{\theta,JA}$  is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta,JC}$  is guaranteed by design while  $R_{\theta,CA}$  is determined by the user's board design.



 a. 42 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 105 °C/W when mounted on a minimum pad of 2 oz copper

c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

g. 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

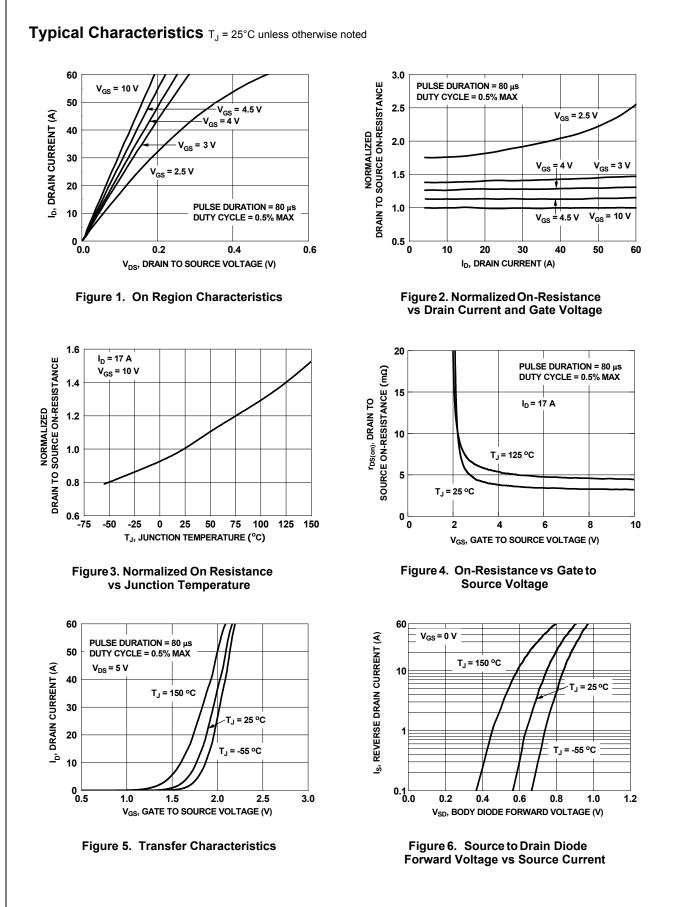
I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

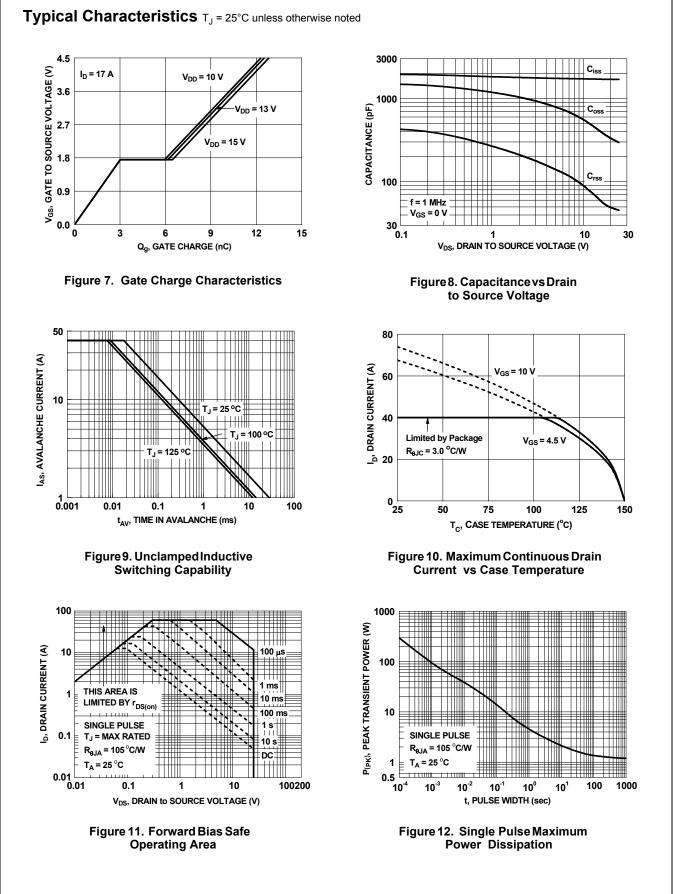
2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.

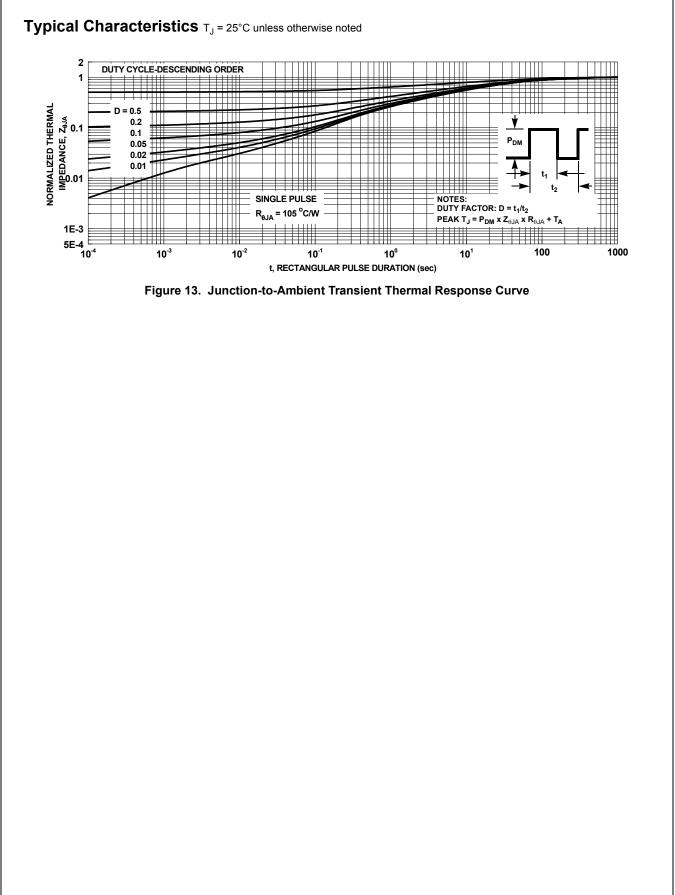
3.  $E_{AS}$  of 29 mJ is based on starting  $T_J$  = 25 °C, L = 1.2 mH,  $I_{AS}$  = 7 A,  $V_{DD}$  = 23 V,  $V_{GS}$  = 10V. 100% tested at L = 0.1 mH,  $I_{AS}$  = 16 A.

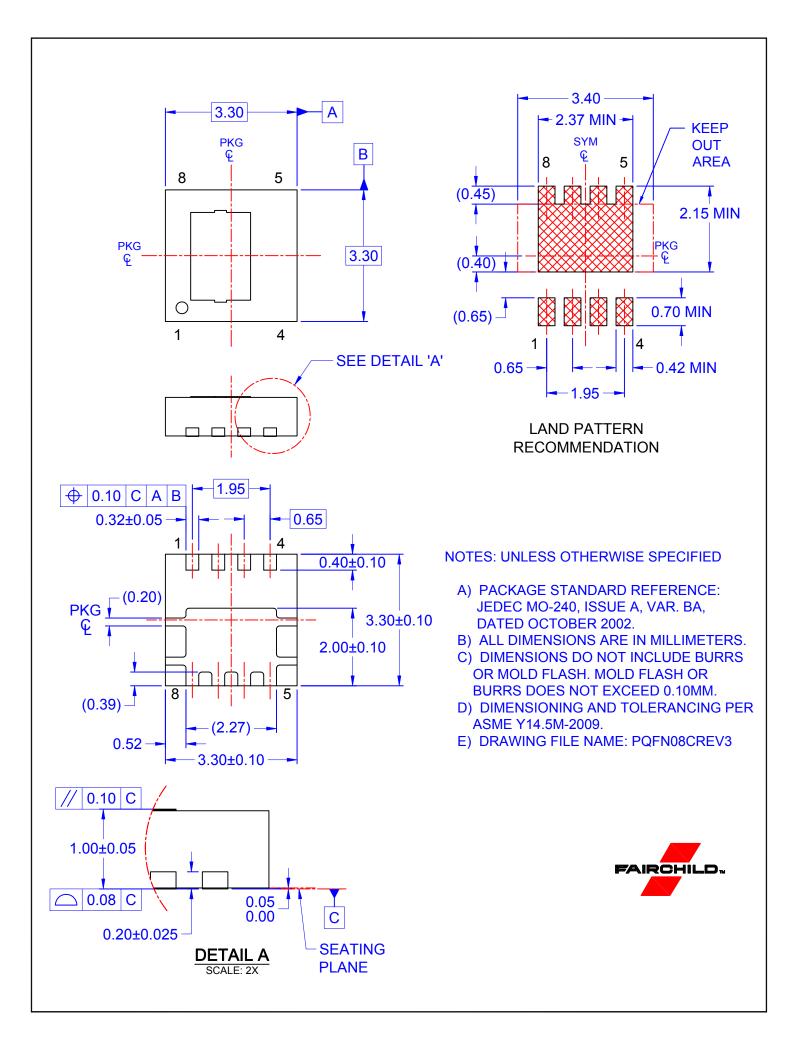
4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

5. The continuous Vds rating is 25V; however, a pulse of 28 V peak voltage for no longer than 3ns duration at 500KHz frequency can be applied.











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